# imall

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SEMICONDUCTOR®

### FDMA1027PT Dual P-Channel PowerTrench<sup>®</sup> MOSFET

### –20 V, –3 A, 120 m $\Omega$

#### Features

- Max  $r_{DS(on)}$  = 120 m $\Omega$  at V<sub>GS</sub> = -4.5 V, I<sub>D</sub> = -3.0 A
- Max r<sub>DS(on)</sub> = 160 mΩ at V<sub>GS</sub> = -2.5 V, I<sub>D</sub> = -2.5 A
- Max r<sub>DS(on)</sub> = 240 mΩ at V<sub>GS</sub> = -1.8 V, I<sub>D</sub> = -1.0 A
- Low profile 0.55 mm maximum in the new package MicroFET 2x2 Thin
- RoHS Compliant
- Free from halogenated compounds and antimony oxides



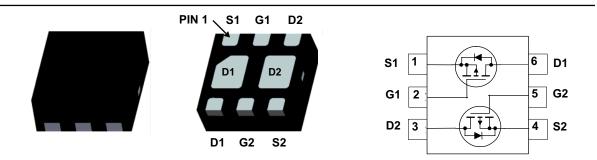
#### **General Description**

This device is designed specifically as a single package solution for the battery charge switch in cellular handset and other ultra-portable applications. It features two independent P-Channel MOSFETs with low on-state resistance for minimum conduction losses. When connected in the typical common source configuration, bi-directional current flow is possible.

The MicroFET 2x2 **Thin** package offers exceptional thermal performance for it's physical size and is well suited to linear mode applications.

#### Applications

- Battery management
- Load switch
- Battery protection



#### MicroFET 2X2 Thin

MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			-20	V	
V <sub>GS</sub>	Gate to Source Voltage			±8	V	
I <sub>D</sub>	Drain Current -Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	-3	•	
	-Pulsed			-6	— A	
D	Power Dissipation for Single Operation	T <sub>A</sub> = 25 °C	(Note 1a)	1.4	w	
P <sub>D</sub>	Power Dissipation for Single Operation	T <sub>A</sub> = 25 °C	(Note 1b)	0.7	VV	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperat	ture Range		-55 to +150	°C	

#### **Thermal Characteristics**

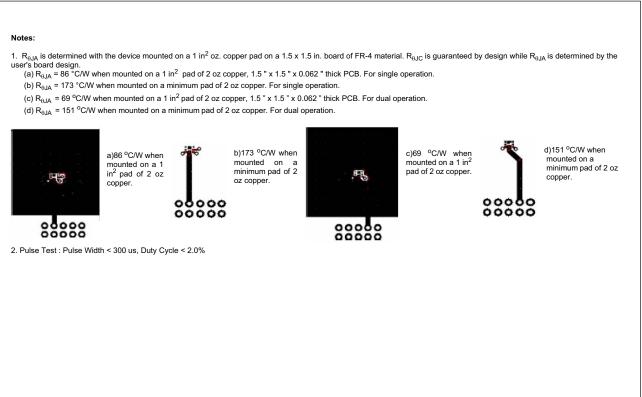
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Single Operation)	(Note 1a)	86	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Single Operation)	(Note 1b)	173	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Dual Operation)	(Note 1c)	69	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Dual Operation)	(Note 1d)	151	

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
27	FDMA1027PT	MicroFET 2x2 Thin	7 "	8 mm	3000 units

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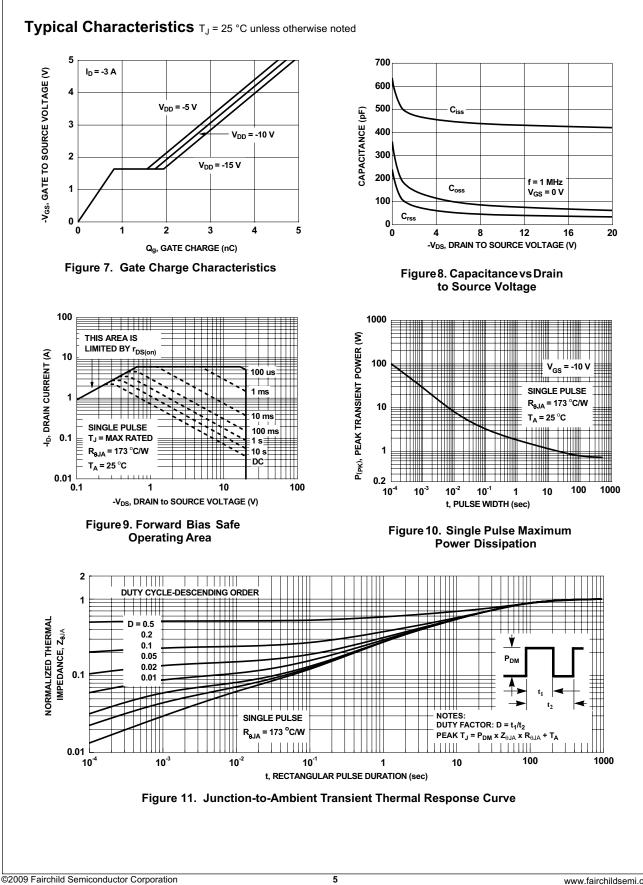
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	cteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = -250 μA, V <sub>GS</sub> = 0 V	-20			V	
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, referenced to 25 °C		-12		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -16 V, V <sub>GS</sub> = 0 V			-1	μA	
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±8 V, V <sub>DS</sub> = 0 V			±100	nA	
On Chara	cteristics			·		•	
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = -250 μA	-0.4	-0.7	-1.3	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, referenced to 25 °C		2		mV/°C	
r <sub>DS(on)</sub>	Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -3.0 \text{ A}$		90	120		
		$V_{GS} = -2.5 \text{ V}, I_D = -2.5 \text{ A}$		120	160	1	
		$V_{GS} = -1.8 \text{ V}, I_D = -1.0 \text{ A}$		172	240	mΩ	
		V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -3.0 A , T <sub>J</sub> = 125 °C		118	160		
I <sub>D(on)</sub>	On to State Drain Current	$V_{GS}$ = -4.5 V, $V_{DS}$ = -5 V	-20			A	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5 V, I_{D} = -3.0 A$		7		S	
Jynamic	Characteristics						
C <sub>iss</sub> C <sub>oss</sub>	Input Capacitance Output Capacitance	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		435 80		pF pF	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	55 55				•	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switching	Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics	55 55		80 45		pF	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switching	Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time	f = 1 MHz		80 45 9	18	pF	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switching	Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Rise Time	f = 1 MHz		80 45 9 11	19	pF pF	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switching t <sub>d(on)</sub> t <sub>r</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	f = 1 MHz		80 45 9 11 15	19 27	pF pF ns	
$C_{iss}$ $C_{oss}$ $C_{rss}$ <b>Switching</b> $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	f = 1 MHz		80 45 9 11 15 6	19 27 12	pF pF ns ns ns ns	
$\begin{array}{c} C_{\mathrm{iss}} \\ C_{\mathrm{oss}} \\ C_{\mathrm{rss}} \end{array} \\ \hline \\ \begin{array}{c} Switching \\ t_{\mathrm{d}(\mathrm{on})} \\ t_{\mathrm{r}} \\ t_{\mathrm{r}} \\ t_{\mathrm{d}(\mathrm{off})} \\ t_{\mathrm{f}} \\ Q_{\mathrm{g}} \end{array} \end{array}$	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance <b>Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge	$ f = 1 \text{ MHz} $ $ V_{DD} = -10 \text{ V}, \text{ I}_D = -1.0 \text{ A} $ $ V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega $		80 45 9 11 15 6 4	19 27	pF pF ns ns ns nc	
$\begin{array}{c} C_{\mathrm{iss}} \\ C_{\mathrm{oss}} \\ C_{\mathrm{rss}} \\ \end{array} \\ \begin{array}{c} Switching \\ t_{\mathrm{d(on)}} \\ t_{\mathrm{r}} \\ t_{\mathrm{r}} \\ t_{\mathrm{d(off)}} \\ t_{\mathrm{f}} \\ Q_{\mathrm{g}} \end{array}$	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance <b>Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Gate to Source Gate Charge	f = 1 MHz		80 45 9 11 15 6 4 0.8	19 27 12	pF pF ns ns ns nc nC	
$C_{iss}$ $C_{oss}$ $C_{rss}$ <b>Switching</b> $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance <b>Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge	$f = 1 \text{ MHz}$ $V_{DD} = -10 \text{ V}, \text{ I}_{D} = -1.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{DD} = -10 \text{ V}, \text{ I}_{D} = -3.0 \text{ A}$		80 45 9 11 15 6 4	19 27 12	pF pF ns ns ns nc	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switching t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gg</sub>	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance <b>Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Gate to Source Gate Charge	$f = 1 \text{ MHz}$ $V_{DD} = -10 \text{ V}, \text{ I}_{D} = -1.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{DD} = -10 \text{ V}, \text{ I}_{D} = -3.0 \text{ A}$		80 45 9 11 15 6 4 0.8	19 27 12	pF pF ns ns ns nc nC	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switching t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-Sou	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance <b>Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge	$f = 1 \text{ MHz}$ $V_{DD} = -10 \text{ V}, I_D = -1.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DD} = -10 \text{ V}, I_D = -3.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}$		80 45 9 11 15 6 4 0.8	19 27 12	pF pF ns ns ns nc nC	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> Switching t <sub>d(on)</sub> t <sub>r</sub> C <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gd</sub> Drain-Sou	Input Capacitance Output Capacitance Reverse Transfer Capacitance <b>Characteristics</b> Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Gate Charge Gate to Drain "Miller" Charge	$f = 1 \text{ MHz}$ $V_{DD} = -10 \text{ V}, I_D = -1.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DD} = -10 \text{ V}, I_D = -3.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}$ Forward Current		80 45 9 11 15 6 4 0.8	19 27 12 6	pF pF ns ns ns nC nC	
$\begin{array}{c} C_{\mathrm{iss}} \\ C_{\mathrm{oss}} \\ C_{\mathrm{rss}} \end{array} \\ \hline \\ \begin{array}{c} \textbf{Switching} \\ \textbf{Switching} \\ \hline \\ \hline \\ \textbf{Switching} \\ \hline \\ \hline \\ \textbf{Switching} \\ \hline \\ \hline \hline \\ \textbf{Switching} \\ \hline \hline \\ \hline \\ \textbf{Switching} \\ \hline \hline \\ \hline \hline \hline \hline \\ \hline \hline \hline \hline \\ \hline \hline \hline \hline \hline \\ \hline \hline$	Input Capacitance         Output Capacitance         Reverse Transfer Capacitance <b>Characteristics</b> Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge <b>Jrce Diode Characteristics</b> Maximum continuous Source-Drain Diode	$f = 1 \text{ MHz}$ $V_{DD} = -10 \text{ V}, I_D = -1.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DD} = -10 \text{ V}, I_D = -3.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}$ Forward Current		80 45 9 11 15 6 4 0.8 0.9	19 27 12 6 -1.1	pF pF ns ns ns nC nC nC	



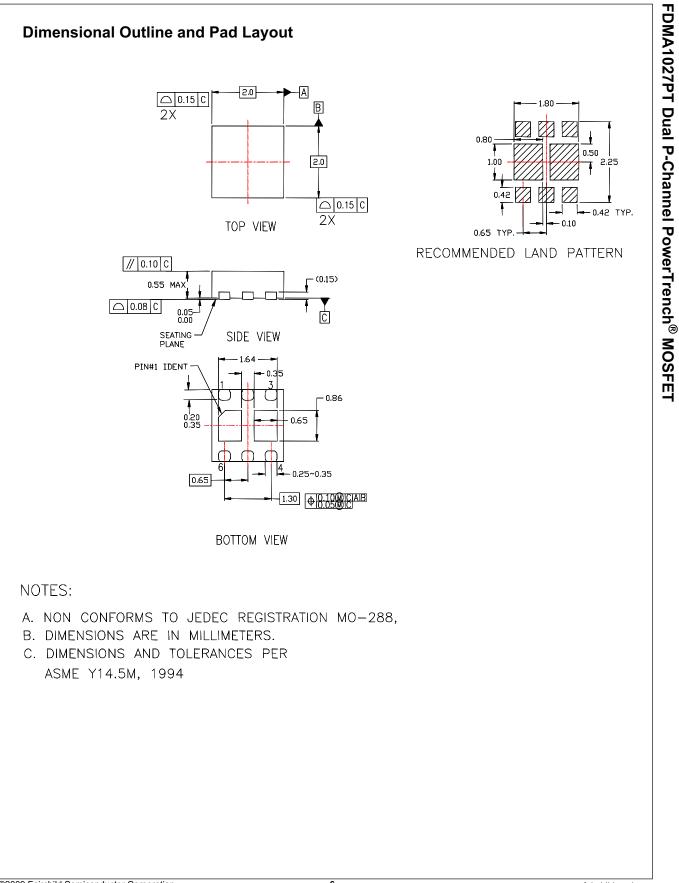
Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted 6 3.0 = -4.5 V NORMALIZED DRAIN TO SOURCE ON-RESISTANCE PULSE DURATION = 300 µs 100 5 DUTY CYCLE = 2%MAX H<sub>D</sub>, DRAIN CURRENT (A) 2.5 V<sub>GS</sub> = -2 V -3.5 4 -2 V V<sub>GS</sub> 2.0 V<sub>GS</sub> = -1.8 V 3 V<sub>GS</sub> = -3 V V<sub>GS</sub> = -2.5 V 1.5 V<sub>GS</sub> = -2.5 V 2 1.0 V<sub>GS</sub> = -1.5 V 1 PULSE DURATION = 300 µs - - 3 V V<sub>GS</sub> -3.5 V V<sub>GS</sub> = -4.5 V V<sub>GS</sub> DUTY CYCLE = 2% MAX 0 0.5 0 0.5 1.0 1.5 2.0 2.5 0 2 3 4 5 6 -ID, DRAIN CURRENT (A) -V<sub>DS</sub>, DRAIN TO SOURCE VOLTAGE (V) Figure 2. Normalized On-Resistance Figure 1. On Region Characteristics vs Drain Current and Gate Voltage 1.4 0.28 I<sub>D</sub> = -3 A NORMALIZED DRAIN TO SOURCE ON-RESISTANCE PULSE DURATION = 300 µs V<sub>GS</sub> = -4.5 V DUTY CYCLE = 2% MAX 1.3 I<sub>D</sub> = -1.5 A r<sub>DS(on)</sub>, DRAIN TO 1.2 1.1 T<sub>J</sub> = 125 °C 1.0 0.9 T<sub>J</sub> = 25 °C 0.8 0.04 , -50 -25 100 125 150 0 25 50 75 0 2 4 6 8 10 TJ, JUNCTION TEMPERATURE (°C) -VGS, GATE TO SOURCE VOLTAGE (V) Figure 3. Normalized On Resistance Figure 4. On-Resistance vs Gate to Source Voltage vs Junction Temperature 6 10 PULSE DURATION = 300 μs DUTY CYCLE = 2% MAX Hs, REVERSE DRAIN CURRENT (A)  $V_{GS} = 0 V$ 5 1 -I<sub>D</sub>, DRAIN CURRENT (A) V<sub>DS</sub> = -5 V T<sub>J</sub> = 125 °C 4 0.1 3 T<sub>J</sub> = 25 °C 0.01 2 T<sub>J</sub> = 125 °C T<sub>J</sub> = 25 °C 0.001 T\_ = -55 °C 1 T<sub>J</sub> = -55 °C 0 0.0001 0.5 2.0 2.5 0 1.0 1.5 0.2 0.4 0.6 0.8 1.0 1.2 -VSD, BODY DIODE FORWARD VOLTAGE (V) -VGS, GATE TO SOURCE VOLTAGE (V) Figure 5. Transfer Characteristics Figure 6. Source to Drain Diode Forward Voltage vs Source Current

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FDMA1027PT Rev.B4

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
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